

August 1989 Revised August 2000

100329

Low Power Octal ECL/TTL Bidirectional Translator with Register

General Description

The 100329 is an octal registered bidirectional translator designed to convert TTL logic levels to 100K ECL logic levels and vice versa. The direction of the translation is determined by the DIR input. A LOW on the output enable input (OE) holds the ECL outputs in a cut-off state and the TTL outputs at a high impedance level. The outputs change synchronously with the rising edge of the clock input (CP) even though only one output is enabled at the time.

The cut-off state is designed to be more negative than a normal ECL LOW level. This allows the output emitter-followers to turn off when the termination supply is –2.0V, presenting a high impedance to the data bus. This high impedance reduces the termination power and prevents loss of low state noise margin when several loads share the bus.

The 100329 is designed with FASTTM TTL output buffers, featuring optimal DC drive and capable of quickly charging and discharging highly capacitive loads. All inputs have 50 k Ω pull-down resistors.

Features

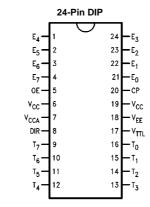
- Bidirectional translation
- ECL high impedance outputs
- Registered outputs
- FAST TTL outputs
- 3-STATE outputs
- Voltage compensated operating range = -4.2V to -5.7V
- High drive IOS

Ordering Code:

Order Number	Package Number	Package Description
100329PC	N24E	24-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-010, 0.400 Wide
100329QC	V28A	28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square
100329QI		28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Industrial Temperature Range (-40°C to +85°C)

Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

Connection Diagrams



28-Pin PLCC

T₁ T₂ T₃V_{EES} T₄ T₅ T₆

11 10 9 8 7 6 5

T₀ 12

V_{TIT} 13

V_{EE} 14

V_{EE} 19

V_{CC} 19

V_{CC} 19

V_C 27 0E

E₀ 18

19 20 21 22 23 24 25

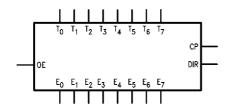
E₁ E₂ E₃V_{EES} E₄ E₅ E₆

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DS010583

Logic Symbol



Pin Descriptions

Pin Names	Description
E ₀ –E ₇	ECL Data I/O
E ₀ –E ₇ T ₀ –T ₇	TTL Data I/O
OE	Output Enable Input
CP	Clock Pulse Input (Active Rising Edge)
DIR	Direction Control Input

All pins function at 100K ECL levels except for T₀-T₇.

Truth Table

OE	E DIR CP EC		ECL	TTL	Notes		
OE.	DIK	CF	Port	Port	notes		
L	L	Χ	Input	Z	(Note 1)(Note 3)		
L	Н	Х	LOW	Input	(Note 2)(Note 3)		
			(Cut-Off)				
Н	L	\	L	L	(Note 1)		
Н	L	_	Н	Н	(Note 1)		
Н	L	L	Х	NC	(Note 1)(Note 3)		
Н	Н	_	L	L	(Note 2)		
Н	Н	\	Н	Н	(Note 2)		
Н	Н	L	NC	Χ	(Note 2)(Note 3)		

- H = HIGH Voltage Level

- The Find Noting bevel

 Le LOW Voltage Level

 X = Don't Care

 Z = High Impedance

 → = LOW-to-HIGH Clock Transition

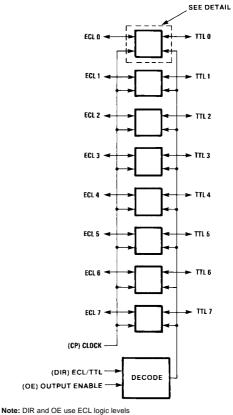
 NC = No Change

Note 1: ECL input to TTL output mode.

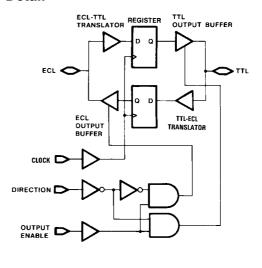
Note 2: TTL input to ECL output mode.

Note 3: Retains data present before CP.

Functional Diagram



Detail



0°C to +85°C

-5.7V to -4.2V

+4.5V to +5.5V

Absolute Maximum Ratings(Note 4)

Recommended Operating $_{-65^{\circ}\text{C to}}\,_{+150^{\circ}\text{C}}$ Conditions

Case Temperature (T_C)

-7.0V to +0.5V ECL Supply Voltage (V_{EE})

-0.5V to +6.0V TTL Supply Voltage (V_{TTL})

Storage Temperature (T_{STG}) Maximum Junction Temperature (T_i) +150°C

V_{FF} Pin Potential to Ground Pin V_{TTL} Pin Potential to Ground Pin

ECL Input Voltage (DC)

ECL Output Current

(DC Output HIGH) TTL Input Voltage (Note 6) TTL Input Current (Note 6)

Voltage Applied to Output

in HIGH State

3-STATE Output

Current Applied to TTL

Output in LOW State (Max) ESD (Note 5)

 V_{EE} to +0.5V

-0.5V to +6.0V -30 mA to +5.0 mA

-50 mA

Note 4: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical -0.5V to +5.5V Characteristics tables are not guaranteed at the absolute maximum rating.

The "Recommended Operating Conditions" table will define the conditions for actual device operation.

twice the rated I_{OL} (mA) Note 5: ESD testing conforms to MIL-STD-883, Method 3015.

 \geq 2000V Note 6: Either voltage limit or current limit is sufficient to protect inputs.

TTL-to-ECL DC Electrical Characteristics

 $V_{EE} = -4.2V$ to -5.7V, $V_{CC} = V_{CCA} = GND$, $T_{C} = 0^{\circ}C$ to $+85^{\circ}C$, $V_{TTL} = +4.5V$ to +5.5V (Note 7)

Symbol	Parameter	Min	Тур	Max	Units	Conditions
V _{OH}	Output HIGH Voltage	-1025	-955	-870	mV	$V_{IN} = V_{IH}$ (Max) or V_{IL} (Min)
V _{OL}	Output LOW Voltage	-1830	-1705	-1620	mV	Loading with 50Ω to –2V
	Cutoff Voltage					OE or DIR LOW,
			-2000	-1950	mV	$V_{IN} = V_{IH}$ (Max) or V_{IL} (Min)
						Loading with 50Ω to $-2V$
V _{OHC}	Output HIGH Voltage	102F			mV	
	Corner Point HIGH	-1035				$V_{IN} = V_{IH}$ (Min) or V_{IL} (Max)
V _{OLC}	Output LOW Voltage			-1610	mV	Loading with 50Ω to –2V
	Corner Point LOW			-1610	mv	
V _{IH}	Input HIGH Voltage	2.0		5.0	V	Over V _{TTL} , V _{EE} , T _C Range
V _{IL}	Input LOW Voltage	0		0.8	V	Over V _{TTL} , V _{EE} , T _C Range
I _{IH}	Input HIGH Current			70	μΑ	V _{IN} = +2.7V
	Breakdown Test			1.0	mA	V _{IN} = +5.5V
I _{IL}	Input LOW Current	-700			μΑ	$V_{IN} = +0.5V$
V_{FCD}	Input Clamp	-1.2			V	I _{IN} = -18 mA
	Diode Voltage	-1.2			V	I _{IN} = -16 IIIA
I _{EE}	V _{EE} Supply Current					LE LOW, OE and DIR HIGH
						Inputs Open
		-189		-94	mA	$V_{EE} = -4.2V \text{ to } -4.8V$
		-199		-94		$V_{EE} = -4.2V \text{ to } -5.7V$

Note 7: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

ECL-to-TTL DC Electrical Characteristics

V_{EE} = -4.2V to -5.7V, V_{CC} = V_{CCA} = GND, T_C = 0°C to +85°C, C_L = 50 pF, V_{TTL} = +4.5V to +5.5V (Note 8)

Symbol	Parameter	Min	Тур	Max	Units	Conditions
V _{OH}	Output HIGH Voltage	2.7	3.1		V	$I_{OH} = -3 \text{ mA}, V_{TTL} = 4.75 \text{V}$
		2.4	2.9		V	$I_{OH} = -3 \text{ mA}, V_{TTL} = 4.50V$
V _{OL}	Output LOW Voltage		0.3	0.5	V	I _{OL} = 24 mA, V _{TTL} = 4.50V
V_{IH}	Input HIGH Voltage	-1165		-870	mV	Guaranteed HIGH Signal
						for All Inputs
V _{IL}	Input LOW Voltage	-1830		-1475	mV	Guaranteed LOW Signal
						for All Inputs
I _{IH}	Input HIGH Current			350	μΑ	V _{IN} = V _{IH} (Max)
I _{IL}	Input LOW Current	0.50			μΑ	V _{IN} = V _{IL} (Min)
I _{OZHT}	3-STATE Current			70	μΑ	V _{OUT} = +2.7V
	Output HIGH					
I _{OZLT}	3-STATE Current	-700			μΑ	$V_{OUT} = +0.5V$
	Output LOW					
los	Output Short-Circuit	-225		-100	mA	$V_{OUT} = 0.0V, V_{TTL} = +5.5V$
	Current					
I _{TTL}	V _{TTL} Supply Current			74	mA	TTL Outputs LOW
				49	mA	TTL Outputs HIGH
				67	mA	TTL Outputs in 3-STATE

Note 8: The specified limits represent the "worst case" value for the parameter. Since these values normally occur at the temperature extremes, additional noise immunity and guardbanding can be achieved by decreasing the allowable system operating ranges. Conditions for testing shown in the tables are chosen to guarantee operation under "worst case" conditions.

DIP TTL-to-ECL AC Electrical Characteristics

 $V_{EE} = -4.2 V$ to -5.7 V, $V_{TTL} = +4.5 V$ to +5.5 V, $V_{CC} = V_{CCA} = GND$

Symbol	Parameter	T _C =	$T_C = 0^{\circ}C$		T _C = 25°C		T _C = 85°C		Conditions
Cymbol		Min	Max	Min	Max	Min	Max	Units	Conditions
f _{MAX}	Max Toggle Frequency	350		350		350		MHz	
t _{PLH}	CP to E _n	1.7	3.6	1.7	3.7	1.9	3.9	ns	Figures 1, 2
t _{PHL}									
t _{PZH}	OE to E _n	1.3	4.2	1.5	4.4	1.7	4.8	ns	Figures 1, 2
	(Cutoff to HIGH)								
t _{PHZ}	OE to E _n	1.5	4.5	1.6	4.5	1.6	4.6	ns	Figures 1, 2
	(HIGH to Cutoff)								
t _{PHZ}	DIR to E _n	1.6	4.3	1.6	4.3	1.7	4.5	ns	Figures 1, 2
	(HIGH to Cutoff)								
t _{SET}	T _n to CP	1.1		1.1		1.1		ns	Figures 1, 2
t _{HOLD}	T _n to CP	1.7		1.7		1.9		ns	Figures 1, 2
t _{PW} (H)	Pulse Width CP	2.1		2.1		2.1		ns	Figures 1, 2
t _{TLH}	Transition Time	0.6	1.6	0.6	1.6	0.6	1.6	ns	Figures 1, 2
t_{THL}	20% to 80%, 80% to 20%								

DIP ECL-to-TTL AC Electrical Characteristics

 $V_{EE} = -4.2 V$ to -5.7 V, $V_{TTL} = +4.5 V$ to +5.5 V, $V_{CC} = V_{CCA} = GND$, $C_L = 50 \ pF$

Symbol	Parameter	T _C =	T _C = 0°C		T _C = 25°C		T _C = 85°C		Conditions
		Min	Max	Min	Max	Min	Max	Units	Conditions
f _{MAX}	Max Toggle Frequency	125		125		125		MHz	
t _{PLH}	CP to T _n	3.1	7.2	3.1	7.2	3.3	7.7	ns	Figures 3, 4
t _{PHL}									
t _{PZH}	OE to T _n	3.4	8.45	3.7	8.95	4.0	9.7	ns	Figures 3, 5
t _{PZL}	(Enable Time)	3.8	9.2	4.0	9.2	4.3	9.95	115	
t _{PHZ}	OE to T _n	3.2	8.95	3.3	8.95	3.5	9.2	ns	Figures 3, 5
t_{PLZ}	(Disable Time)	3.0	7.7	3.4	8.7	4.1	9.95	115	
t _{PHZ}	DIR to T _n	2.7	8.2	2.8	8.7	3.1	8.95		Figures 3, 6
t _{PLZ}	(Disable Time)	2.8	7.45	3.1	7.95	4.0	9.2	ns	rigules 3, 6
t _{SET}	E _n to CP	1.1		1.1		1.1		ns	Figures 3, 4
t _{HOLD}	E _n to CP	2.1		2.1		2.6		ns	Figures 3, 4
t _{PW} (H)	Pulse Width CP	4.1		4.1		4.1		ns	Figures 3, 4

PLCC and TTL-to-ECL AC Electrical Characteristics

 $V_{\mbox{\footnotesize EE}} = -4.2 \mbox{\footnotesize V}$ to $-5.7 \mbox{\footnotesize V}, \mbox{\footnotesize V}_{\mbox{\footnotesize TTL}} = +4.5 \mbox{\footnotesize V}$ to $+5.5 \mbox{\footnotesize V}$

Symbol	Parameter	T _C = 0°C		T _C = 25°C		T _C = 85°C		Units	Conditions
Symbol		Min	Max	Min	Max	Min	Max	Units	Conditions
f _{MAX}	Max Toggle Frequency	350		350		350		MHz	
t _{PLH}	CP to E _n	1.7	3.4	1.7	3.5	1.9	3.7	ns	Figures 1, 2
t_{PHL}									
t _{PZH}	OE to E _n	1.3	4.0	1.5	4.2	1.7	4.6	ns	Figures 1, 2
	(Cutoff to HIGH)								
t _{PHZ}	OE to E _n	1.5	4.3	1.6	4.3	1.6	4.4	ns	Figures 1, 2
	(HIGH to Cutoff)								
t _{PHZ}	DIR to E _n	1.6	4.1	1.6	4.1	1.7	4.3	ns	Figures 1, 2
	(HIGH to Cutoff)								
t _{SET}	T _n to CP	1.0		1.0		1.0		ns	Figures 1, 2
t _{HOLD}	T _n to CP	1.7		1.7		1.9		ns	Figures 1, 2
t _{PW} (H)	Pulse Width CP	2.0		2.0		2.0		ns	Figures 1, 2
t _{TLH}	Transition Time	0.6	1.6	0.6	1.6	0.6	1.6	ns	Figures 1, 2
t_{THL}	20% to 80%, 80% to 20%								
toshl	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		200		200		200	ps	(Note 9)
	Data to Output Path								
t _{OSLH}	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		200		200		200	ps	(Note 9)
	Data to Output Path								
t _{OST}	Maximum Skew Opposite Edge								PLCC Only
	Output-to-Output Variation		650		650		650	ps	(Note 9)
	Data to Output Path								
t _{PS}	Maximum Skew								PLCC Only
	Pin (Signal) Transition Variation		650		650		650	ps	(Note 9)
	Data to Output Path								

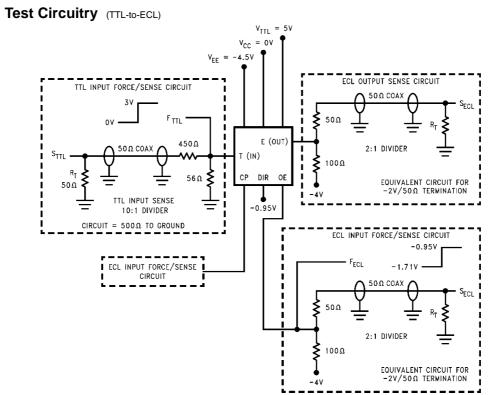
Note 9: Output-to-Output Skew is defined as the absolute value of the difference between the actual propagation delay for any outputs within the same packaged device. The specifications apply to any outputs switching in the same direction either HIGH-to-LOW (t_{OSHL}), or LOW-to-HIGH (t_{OSLH}), or in opposite directions both HL and LH (t_{OST}). Parameters t_{OST} and t_{PS} guaranteed by design.

PLCC and ECL-to-TTL AC Electrical Characteristics

 $\mbox{V}_{EE} = -4.2\mbox{V}$ to $-5.7\mbox{V}, \mbox{ V}_{TTL} = +4.5\mbox{V}$ to $+5.5\mbox{V}, \mbox{ C}_L = \mbox{50 pF}$

Cumbal	Parameter	$T_C = 0^{\circ}C$		$T_C = 25^{\circ}C$		T _C =	85°C	Units	Conditions
Symbol		Min	Max	Min	Max	Min	Max	Units	Conditions
f _{MAX}	Max Toggle Frequency	125		125		125		MHz	
t _{PLH}	CP to T _n	3.1	7.0	3.1	7.0	3.3	7.5	ns	Figures 3, 4
t _{PHL}									
t _{PZH}	OE to T _n	3.4	8.25	3.7	8.75	4.0	9.5	ns	Figures 3, 5
t _{PZL}	(Enable Time)	3.8	9.0	4.0	9.0	4.3	9.75		
t _{PHZ}	OE to T _n	3.2	8.75	3.3	8.75	3.5	9.0	ns	Figures 3, 5
t _{PLZ}	(Disable Time)	3.0	7.5	3.4	8.5	4.1	9.75		
t _{PHZ}	DIR to T _n	2.7	8.0	2.8	8.5	3.1	8.75	ns	Figures 3, 6
t _{PLZ}	(Disable Time)	2.8	7.25	3.1	7.75	4.0	9.0		
t _{SET}	E _n to CP	1.0		1.0		1.0		ns	Figures 3, 4
t _{HOLD}	E _n to CP	2.0		2.0		2.5		ns	Figures 3, 4
t _{PW} (H)	Pulse Width CP	4.0		4.0		4.0		ns	Figures 3, 4
t _{OSHL}	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		600		600		600	ps	(Note 10)
	Data to Output Path								
toslh	Maximum Skew Common Edge								PLCC Only
	Output-to-Output Variation		850		850		850	ps	(Note 10)
	Data to Output Path								
t _{OST}	Maximum Skew Opposite Edge								PLCC Only
	Output-to-Output Variation		1350		1350		1350	ps	(Note 10)
	Data to Output Path								
t _{PS}	Maximum Skew								PLCC Only
	Pin (Signal) Transition Variation		950		950		950	ps	(Note 10)
	Data to Output Path								

Note 10: Output-to-Output Skew is defined as the absolute value of the difference between the actual propagation delay for any outputs within the same packaged device. The specifications apply to any outputs switching in the same direction either HIGH-to-LOW (t_{OSHL}), or LOW-to-HIGH (t_{OSLH}), or in opposite directions both HL and LH (t_{OST}). Parameters t_{OST} and t_{PS} guaranteed by design.



Note 11: $R_T = 50\Omega$ termination resistive load. When an input or output is being monitored by a scope, R_T is supplied by the scope's 50Ω input resistance. When an input or output is not being monitored, an external 50Ω resistance must be applied to serve as R_T .

Note 12: TTL and ECL force signals are brought to the DUT via 50Ω coax lines.

Note 13: V_{TTL} is decoupled to ground with 0.1 μ F, V_{EE} is decoupled to ground with 0.01 μ F and V_{CC} is connected to ground.

FIGURE 1. TTL-to-ECL AC Test Circuit

Switching Waveforms (TTL-to-ECL) TIL DATA CLOCK DIRECTION CONTROL OUTPUT ENABLE ECL OUTPUT tpp ts, th the total to

FIGURE 2. TTL to ECL Transition—Propagation Delay and Transition Times

Test Circuitry (ECL-to-TTL) V_{TTL} = 5V $V_{CC} = 0V$ ECL INPUT FORCE/SENSE CIRCUIT -0.95V F_{ECL} TTL OUTPUT SENSE CIRCUIT 500Ω E (IN) **450**Ω 2:1 DIVIDER T (OUT) **∮** 100Ω C_L EQUIVALENT CIRCUIT FOR -2V/50Ω TERMINATION -1.69V 10:1 DIVIDER ECL INPUT FORCE/SENSE CIRCUIT -0.95V ECL INPUT FORCE/SENSE CIRCUIT $\mathsf{F}_{\mathsf{ECL}}$ 50Ω COAX 100.0 EQUIVALENT CIRCUIT FOR -2V/50Ω TERMINATION

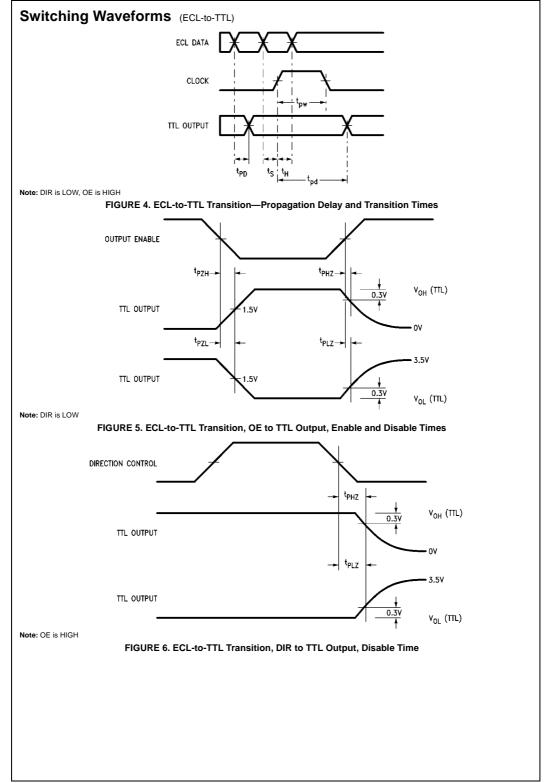
Note 14: $R_T = 50\Omega$ termination resistive load. When an input or output is being monitored by a scope, R_T is supplied by the scope's 50Ω input resistance. When an input or output is not being monitored, an external 50Ω resistance must be applied to serve as R_T .

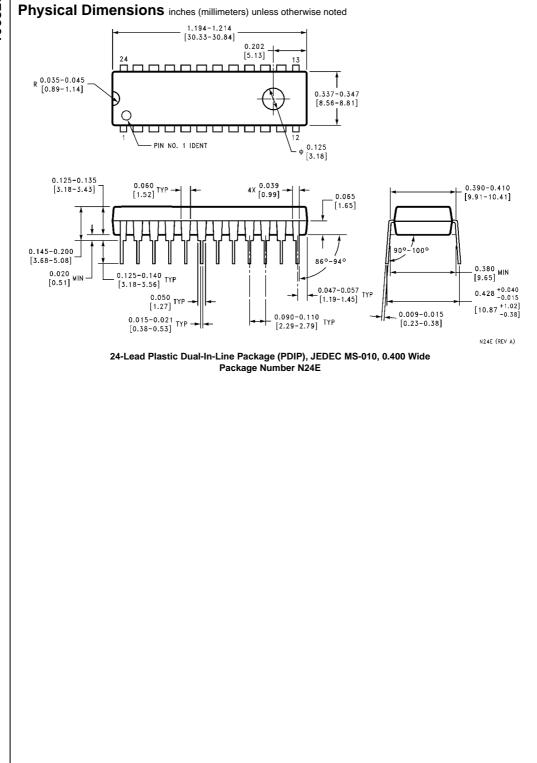
Note 15: The TTL 3-STATE pull-up switch is connected to +7V only for ZL and LZ tests.

Note 16: TTL and ECL force signals are brought to the DUT via 50Ω coax lines.

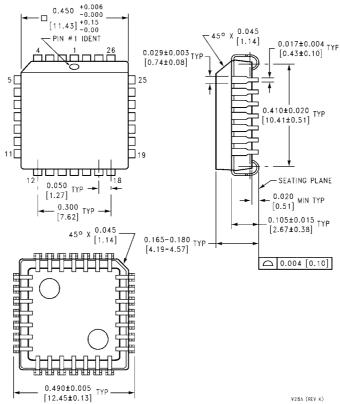
Note 17: V_{TTL} is decoupled to ground with 0.1 μ F, V_{EE} is decoupled to ground with 0.01 μ F and V_{CC} is connected to ground.

FIGURE 3. ECL-to-TTL AC Test Circuit





Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



28-Lead Plastic Lead Chip Carrier (PLCC), JEDEC MO-047, 0.450 Square Package Number V28A

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